

Notice of References Cited	Application/Control No. 10/802,184	Applicant(s)/Patent Under Reexamination YOSHII ET AL.	
	Examiner James A: Dudek	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,380,995	04-2002	Kim, Yong Beom	349/113
*	B	US-2005/0094068	05-2005	Ikeno et al.	349/114
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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